

# アレイ形積層セラミックコンデンサ ARRAY TYPE MULTILAYER CERAMIC CAPACITOR

	code	Temp.characteristics	operating Temp. range
OPERATING TEMP.	BJ	B	-25~+85°C
		X5R	-55~+85°C
	B7	X7R	-55~+125°C
	CH	C0H	-55~+125°C
	CG	C0G	-55~+125°C



リフロー/REFLOW

## 特長 FEATURES

- ・2125形状で4回路構成であるため、より高密度、高効率な実装を実現
- ・1回路あたりの容量は1 $\mu$ Fの大容量
- ・内部電極には、信頼性とコストパフォーマンスに優れたNiを使用しています。
- ・4 circuits in 2125 package allows higher placement density and efficiency
- ・The capacitance in each circuit, F or B dielectric, is 1  $\mu$ F
- ・Internal electrode is nickel for increased cost performance and reliability

## 用途 APPLICATIONS

- ・一般電子機器用
- ・通信機器用 (携帯電話、PHS、コードレス電話etc)
- ・General electronic equipment
- ・Communication equipment (mobile phone, PHS, cordless phone, etc.)

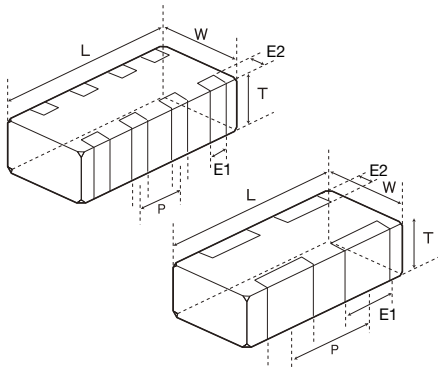
## 形名表記法 ORDERING CODE

<b>1</b> 定格電圧 (VDC)	J 6.3 L 10 E 16 T 25 U 50	<b>3</b> 端子電極	K ムッキ品	<b>5</b> 温度特性	BJ   B $\pm 10$ [%] CG   0 $\pm 30$ [ppm/°C]	<b>7</b> 容量許容差	M $\pm 20$ % K $\pm 10$ % F $\pm 1$ pF	<b>9</b> 個別仕様	- 標準
<b>2</b> シリーズ名	4 4連積層コンデンサ 2 2連積層コンデンサ	<b>4</b> 形状寸法 (EIA) L×W (mm)	096 (0302) 0.9×0.6 110 (0504) 1.4×1.0 212 (0805) 2.0×1.25	<b>6</b> 公称静電容量 (pF)	例 104 100,000 105 1,000,000	<b>8</b> 製品厚み (mm)	P 0.3 K 0.45 B 0.6 A 0.8 D 0.85	<b>10</b> 包装	T テーピング (4mmピッチ・178 $\phi$ ) F テーピング (2mmピッチ・178 $\phi$ )
								<b>11</b> 当社管理記号	$\triangle$ 標準品 $\triangle$ =スペース

<b>1</b> E	<b>2</b> 4	<b>3</b> K	<b>4</b> 2 1 2	<b>5</b> B	<b>6</b> J	<b>7</b> 1	<b>8</b> 0 4	<b>9</b> M	<b>10</b> D	<b>11</b> - T $\bigcirc$
------------	------------	------------	----------------	------------	------------	------------	--------------	------------	-------------	--------------------------

<b>1</b> Rated voltage (VDC)	J 6.3 L 10 E 16 T 25 U 50	<b>3</b> End termination	K Plated	<b>5</b> Temperature characteristics code	BJ   X5R -55~+85°C $\pm 15\%$ B7   X7R -55~+125°C $\pm 15\%$ CG   C0G 0 $\pm 30$ [ppm/°C]	<b>7</b> Capacitance tolerances (%)	M $\pm 20$ K $\pm 10$ F $\pm 1$ pF	<b>9</b> Special code	- Standard products
<b>2</b> Series name	4 4 circuit multilayer capacitors 2 2 circuit multilayer capacitors	<b>4</b> Dimensions (case size) (mm)	096 (0302) 0.9×0.6 110 (0504) 1.4×1.0 212 (0805) 2.0×1.25	<b>6</b> Nominal capacitance (pF)	example 104 100,000 105 1,000,000	<b>8</b> Thickness (mm)	P 0.3 K 0.45 B 0.6 A 0.8 D 0.85	<b>10</b> Packaging	T Tape (4mm pitch・178 $\phi$ ) F Tape (2mm pitch・178 $\phi$ )
								<b>11</b> Internal code	$\triangle$ Standard products $\triangle$ = Blank space

外形寸法 EXTERNAL DIMENSIONS



Type (EIA)	L	W	E1	E2	P	T	
□2K096 (0302)	0.9±0.05 (0.035±0.002)	0.6±0.05 (0.024±0.002)	0.23±0.10 (0.009±0.004)	0.125±0.075 (0.005±0.003)	0.45±0.05 (0.018±0.002)	P	0.30±0.03 (0.012±0.001)
□2K110 (0504)	1.37±0.07 (0.054±0.003)	1.00±0.08 (0.039±0.003)	0.36±0.10 (0.014±0.004)	0.2±0.10 (0.008±0.004)	0.64±0.10 (0.025±0.004)	K	0.45±0.05 (0.018±0.002)
						V	0.5±0.05 (0.020±0.002)
						B	0.60±0.06 (0.024±0.003)
□4K212 (0805)	2.00±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	0.25±0.10 (0.010±0.004)	0.25±0.15 (0.010±0.006)	0.50±0.10 (0.020±0.004)	D	0.85±0.10 (0.033±0.004)
□2K212 (0805)	2.00±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	0.50±0.20 (0.020±0.008)	0.25±0.15 (0.010±0.006)	1.00±0.10 (0.039±0.004)	D	0.85±0.10 (0.033±0.004)

Unit:mm (inch)

概略バリエーション AVAILABLE CAPACITANCE RANGE

BJ/ X7R, BJ/ X5R

Cap [μF]	Type	0906 2連		1410 2連						2125 2連		2125 4連					
	Temp.Char VDC	□2K096		□2K110						□2K212		□4K212					
		B/X5R	X5R	B/X7R		B/X5R		X5R		B/X5R	X5R	B/X7R	B/X5R		X5R		
		[pF:3digits]	10V	6.3V	50V	25V	16V	25V	10V	10V	6.3V	25V	10V	16V	25V	10V	10V
0.001	102					B											
0.0022	222					B											
0.0047	472					B											
0.01	103	P				B											
0.022	223					B											
0.047	473		K				B										
0.1	104		K				B	B					D	D			
0.22	224		K						B							D	
0.47	474							A								D	
1.0	105									A	V	D					D
2.2	225										A		D				

※グラフ記号は製品厚みを表します。 Letters in the table indicate thickness.

CH / C0H/CG (C0G)

Cap [pF]	Type	0906 2連		1410 2連	
	Temp.Char VDC	□2K096		□2K110	
		CH / CG	CH / CG	CH / CG	CH / CG
10	100	P	B		
12	120	P	B		
15	150	P	B		
18	180	P	B		
22	220	P	B		
27	270	P	B		
33	330	P	B		
39	390	P	B		
47	470	P	B		
56	560	P	B		
68	680	P	B		
82	820	P	B		
100	101	P	B		

※グラフ記号は製品厚みを表します。

Letters in the table indicate thickness.

温度特性コード Temp.char.Code	温度特性 Temperature characteristics					静電容量許容差[%] Capacitance tolerance	tan δ [%] Dissipation factor
	準拠規格 Applicable standard		温度範囲[°C] Temperature range	基準温度[°C] Ref. Temp.	静電容量変化率 Capacitance change		
BJ	JIS	B	-25~+85	20	±10[%]	±10 (K) ±20 (M)	3.5, 5, 10 max.*
	EIA	X5R	-55~+85	25	±15[%]		
B7	EIA	X7R	-55~+125	25	±15[%]	±10 (K)	
CH	JIS	CH	-55~+125	20	±60 [ppm/°C]	±10 (K)	0.1 max.**
	EIA	C0H	-55~+125	25	±60 [ppm/°C]		
CG	JIS	CG	-55~+125	20	±30 [ppm/°C]	±10 (K)	0.1 max.**
	EIA	C0G	-55~+125	25	±30 [ppm/°C]		

\*: アイテムによって異なります。アイテム一覧表を参照下さい。

\*\* : 27pF以下 Q≧400+20・C 30pF以上 Q≧1000

\* : Different depending on the item. Please refer to the part numbers list for the differences.

\*\* : 27pF or over Q≧400+20・C 30pF or over Q≧1000

セレクションガイド  
Selection Guide

アイテム一覧  
Part Numbers

特性図  
Electrical Characteristics

梱包  
Packaging

信頼性  
Reliability Data

使用上の注意  
Precautions



etc

# アイテム一覧 PART NUMBERS

## ■ 0906TYPE(0302 case size) 2連タイプ(2 circuit type)

### 【温度特性 Temp.char. BJ:B/X5R】

定格電圧 Rated Voltage	形名 Ordering code		EHS (Environmental Hazardous Substances)	公称 静電容量 Capacitance [ $\mu$ F]	温度特性 Temperature characteristics	tan $\delta$ Dissipation factor [%] Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許容差 Capacitance tolerance	厚み Thickness [mm] [inch]
10V	L2K096 BJ103□P		RoHS	0.01	B/X5R	5	R	±10% [K] ±20% [M]	0.3±0.03 (0.012±0.001)
6.3V	J2K096 BJ473□K*		RoHS	0.047	X5R				
	J2K096 BJ104□K*		RoHS	0.1		10			
	J2K096 BJ224MK*		RoHS	0.22					

### 【温度特性 Temp.char. CH:CH/COH】

定格電圧 Rated Voltage	形名 Ordering code		EHS (Environmental Hazardous Substances)	公称 静電容量 Capacitance [pF]	温度特性 Temperature characteristics	tan $\delta$ Dissipation factor [%] Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許容差 Capacitance tolerance	厚み Thickness [mm] [inch]
25V	T2K096 $\Delta$ 100FP		RoHS	10	CH(C0H)/ CG(C0G)	400+20°C	R	±1pF [F]  ±10% [K]	0.3±0.03 (0.012±0.001)
	T2K096 $\Delta$ 120KP		RoHS	12					
	T2K096 $\Delta$ 150KP		RoHS	15					
	T2K096 $\Delta$ 180KP		RoHS	18					
	T2K096 $\Delta$ 220KP		RoHS	22					
	T2K096 $\Delta$ 270KP		RoHS	27					
	T2K096 $\Delta$ 330KP		RoHS	33		1000(0.1%)			
	T2K096 $\Delta$ 390KP		RoHS	39					
	T2K096 $\Delta$ 470KP		RoHS	47					
	T2K096 $\Delta$ 560KP		RoHS	56					
	T2K096 $\Delta$ 680KP		RoHS	68					
	T2K096 $\Delta$ 820KP		RoHS	82					
	T2K096 $\Delta$ 101KP		RoHS	100					

形名の□には静電容量許容差記号が入ります。 □ Please specify the capacitance tolerance code.

\* 高温負荷試験の試験電圧は、定格電圧の1.5倍 \*Test voltage of loading at high temperature test is 1.5 time of the rated voltage.

注：形名の△には温度特性が入ります。 △ Please specify the temperature characteristic code.

■ 1410TYPE(0504 case size) 2連タイプ(2 circuit type)

【温度特性 Temp.char. BJ:B/X5R】

定格電圧 Rated Voltage	形名 Ordering code	EHS (Environmental Hazardous Substances)	公称 静電容量 Capacitance 〔μF〕	温度特性 Temperature characteristics	tan δ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー- Reflow soldering W: 7口- Wave soldering	静電容量 許容差 Capacitance tolerance	厚み Thickness 〔mm〕 〔inch〕
50V	U2K110 BJ102□B	RoHS	0.001	B/X5R**	3.5	R	±10% [K] ±20% [M]	0.6±0.06 (0.024±0.002)
	U2K110 BJ222□B	RoHS	0.0022					
	U2K110 BJ472□B	RoHS	0.0047					
25V	T2K110 BJ103□B	RoHS	0.01	B/X5R	5	R	±10% [K] ±20% [M]	0.6±0.06 (0.024±0.002)
	T2K110 BJ223□B	RoHS	0.022					
	T2K110 BJ104□B	RoHS	0.1					
16V	E2K110 BJ473□B	RoHS	0.047	B/X5R**	3.5	R	±10% [K] ±20% [M]	0.6±0.06 (0.024±0.002)
	E2K110 BJ104□B	RoHS	0.1					
10V	L2K110 BJ224□B	RoHS	0.22	B/X5R	5	R	±10% [K] ±20% [M]	0.8±0.08 (0.031±0.003)
	L2K110 BJ474□A	RoHS	0.47					
	L2K110 BJ105□A*	RoHS	1.0					
6.3V	J2K110 BJ105□V*	RoHS	1.0	X5R	10	R	±10% [K] ±20% [M]	0.5±0.05 (0.02±0.002)
	J2K110 BJ225□A*	RoHS	2.2					

\*\* 個別仕様の取交しにより、X7R 仕様に対応している場合があります。

\*\*We may provide X7R for some items according to the individual specification.

【温度特性 Temp.char. B7:X7R】

定格電圧 Rated Voltage	形名 Ordering code	EHS (Environmental Hazardous Substances)	公称 静電容量 Capacitance 〔μF〕	温度特性 Temperature characteristics	tan δ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー- Reflow soldering W: 7口- Wave soldering	静電容量 許容差 Capacitance tolerance	厚み Thickness 〔mm〕 〔inch〕
50V	U2K110 B7 102□B	RoHS	0.001	X7R	3.5	R	±10% [K] ±20% [M]	0.6±0.06 (0.024±0.002)
	U2K110 B7 222□B	RoHS	0.0022					
	U2K110 B7 472□B	RoHS	0.0047					
25V	T2K110 B7 103□B	RoHS	0.01	X7R	5	R	±10% [K] ±20% [M]	0.6±0.06 (0.024±0.002)
	T2K110 B7 223□B	RoHS	0.022					
16V	E2K110 B7 473□B	RoHS	0.047	X7R	5	R	±10% [K] ±20% [M]	0.6±0.06 (0.024±0.002)
	E2K110 B7 104□B	RoHS	0.1					

【温度特性 Temp.char. CH:CH/COH】

定格電圧 Rated Voltage	形名 Ordering code	EHS (Environmental Hazardous Substances)	公称 静電容量 Capacitance 〔pF〕	温度特性 Temperature characteristics	tan δ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー- Reflow soldering W: 7口- Wave soldering	静電容量 許容差 Capacitance tolerance	厚み Thickness 〔mm〕 〔inch〕
50V	U2K110 △100FB	RoHS	10	CH(C0H)/ CG(C0G)	400+20・C	R	±10% [K]	0.6±0.06 (0.024±0.002)
	U2K110 △120KB	RoHS	12					
	U2K110 △150KB	RoHS	15					
	U2K110 △180KB	RoHS	18					
	U2K110 △220KB	RoHS	22					
	U2K110 △270KB	RoHS	27					
	U2K110 △330KB	RoHS	33		1000(0.1%)			
	U2K110 △390KB	RoHS	39					
	U2K110 △470KB	RoHS	47					
	U2K110 △560KB	RoHS	56					
	U2K110 △680KB	RoHS	68					
	U2K110 △820KB	RoHS	82					
	U2K110 △101KB	RoHS	100					

形名の□には静電容量許容差記号が入ります。

□ Please specify the capacitance tolerance code.

\* 高温負荷試験の試験電圧は、定格電圧の 1.5 倍

\*Test voltage of loading at high temperature test is 1.5 time of the rated voltage.

注：形名の△には温度特性が入ります。

△ Please specify the temperature characteristic code.

## アイテム一覧 PART NUMBERS

### ■ 2012TYPE(0805 case size) 4連タイプ(4 circuit type)

#### 【温度特性 Temp.char. BJ:B/X5R】

定格電圧 Rated Voltage	形名 Ordering code		EHS (Environmental Hazardous Substances)	公称 静電容量 Capacitance 〔 $\mu$ F〕	温度特性 Temperature characteristics	tan $\delta$ Dissipation factor 〔%〕 Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許容差 Capacitance tolerance	厚み Thickness 〔mm〕 〔inch〕
25V	T4K212 BJ104□D		RoHS	0.1	B/X5R	5	R	±10%〔K〕 ±20%〔M〕	0.85±0.1 (0.033±0.004)
16V	E4K212 BJ104□D		RoHS	0.1	B/X5R**				
10V	L4K212 BJ224□D		RoHS	0.22	B/X5R				
	L4K212 BJ474□D		RoHS	0.47					
	L4K212 BJ105□D*		RoHS	1	X5R	10			

\*\*個別仕様の取交しにより、X7R仕様に対応している場合があります。

\*\*We may provide X7R for some items according to the individual specification.

#### 【温度特性 Temp.char. B7:X7R】

定格電圧 Rated Voltage	形名 Ordering code		EHS (Environmental Hazardous Substances)	公称 静電容量 Capacitance 〔 $\mu$ F〕	温度特性 Temperature characteristics	tan $\delta$ Dissipation factor 〔%〕 Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許容差 Capacitance tolerance	厚み Thickness 〔mm〕 〔inch〕
16V	E4K212 B7 104□D		RoHS	0.1	X7R	5	R	±10%〔K〕 ±20%〔M〕	0.85±0.1 (0.033±0.004)

### ■ 2012TYPE(0805 case size) 2連タイプ(2 circuit type)

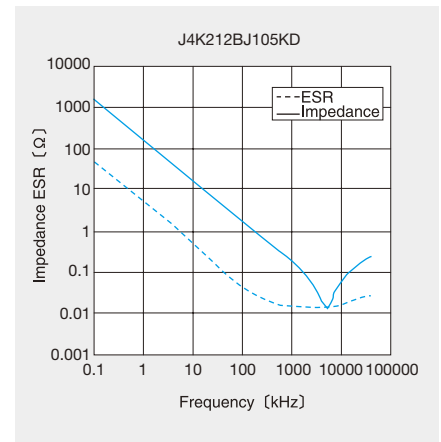
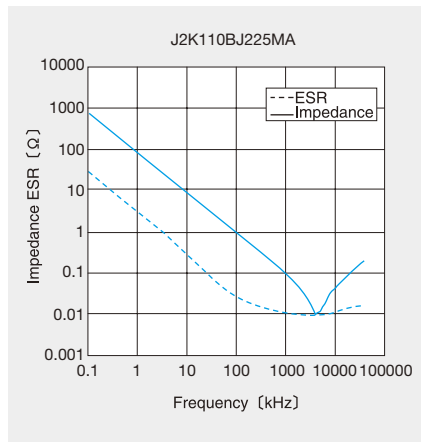
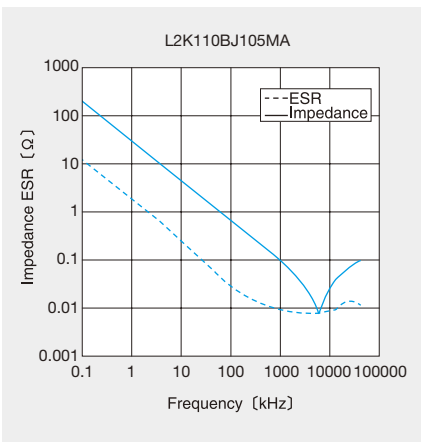
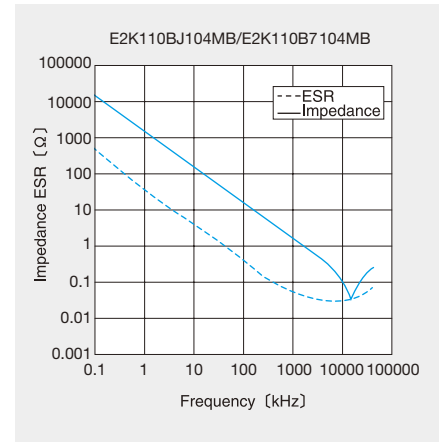
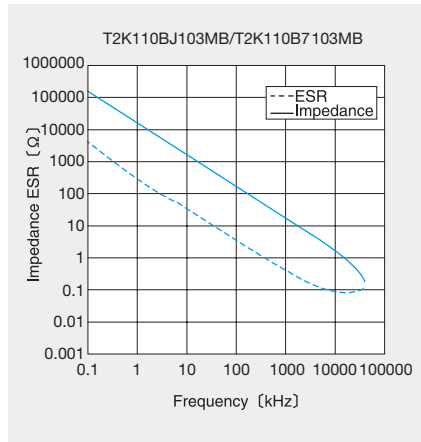
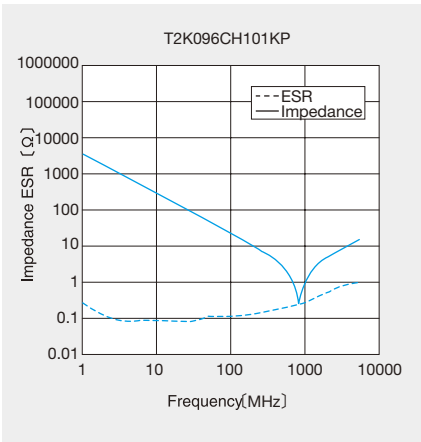
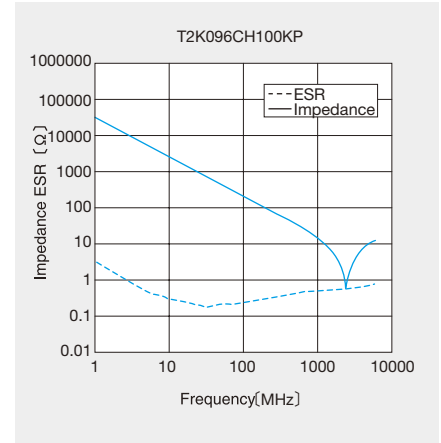
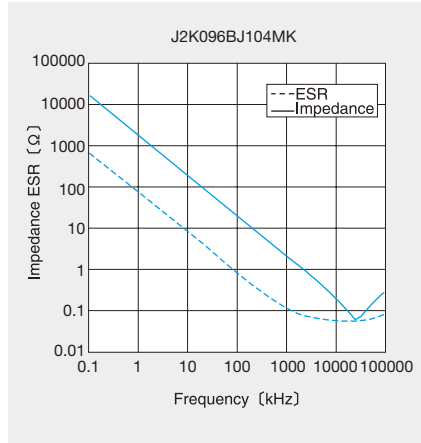
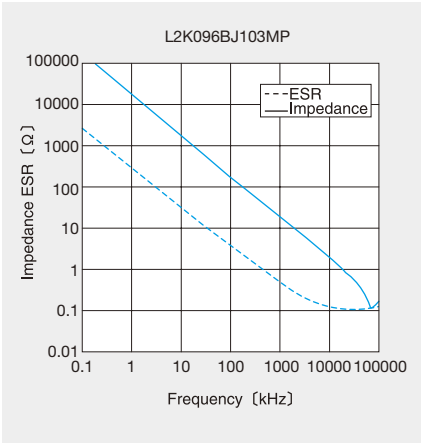
#### 【温度特性 Temp.char. BJ:B/X5R】

定格電圧 Rated Voltage	形名 Ordering code		EHS (Environmental Hazardous Substances)	公称 静電容量 Capacitance 〔 $\mu$ F〕	温度特性 Temperature characteristics	tan $\delta$ Dissipation factor 〔%〕 Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許容差 Capacitance tolerance	厚み Thickness 〔mm〕 〔inch〕
25V	T2K212 BJ105□D		RoHS	1.0	B/X5R	5	R	±10%〔K〕 ±20%〔M〕	0.85±0.1 (0.033±0.004)
10V	L2K212 BJ225MD*		RoHS	2.2	X5R	10			

形名の□には静電容量許容差記号が入ります。 □ Please specify the capacitance tolerance code.

\* 高温負荷試験の試験電圧は、定格電圧の1.5倍 \*Test voltage of loading at high temperature test is 1.5 time of the rated voltage.

インピーダンス・ESR-周波数特性例 Example of Impedance ESR vs. Frequency characteristics  
 ・当社積層セラミックコンデンサ例 (Taiyo Yuden multilayer ceramic capacitor)



# 梱包 PACKAGING

①最小受注単位数 Minimum Quantity

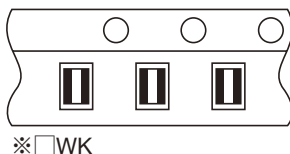
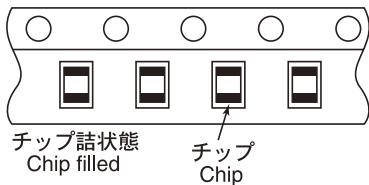
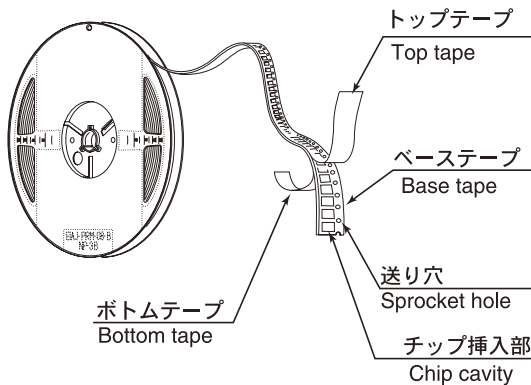
■テーピング梱包 Taped packaging

形式 (EIA) Type	製品厚み Thickness		標準数量 Standard quantity [ pcs ]	
	mm (inch)	code	紙テープ paper	エンボステープ Embossed tape
□MK042 (01005)	0.2 (0.008)	C	15000	—
□MK063 (0201)	0.3 (0.012)	P	15000	—
□2K096 (0302)	0.3 (0.012)	P	10000	—
	0.45 (0.018)	K		
□WK105 (0204)	0.3 (0.012)	P	10000	—
□MK105 (0402)	0.5 (0.020)	V, W	10000	—
□VK105 (0402)		W		
□MK107 (0603)	0.45 (0.018)	K	4000	—
		V		
□WK107 (0306)	0.5 (0.020)	A	4000	—
		Z		
		V		
□2K110 (0504)	0.5 (0.020)	V	4000	—
	0.8 (0.031)	A	4000	—
□MK212 (0805)	0.6 (0.024)	B	4000	—
		K	4000	—
□WK212 (0508)	0.45 (0.018)	K	4000	—
□4K212 (0805)	0.85 (0.033)	D	4000	—
		G		
□2K212 (0805)	1.25 (0.049)	—	3000	—
		D		
□MK316 (1206)	0.85 (0.033)	D	4000	—
		G		
□WK316 (0612)	1.15 (0.045)	F	—	3000
		L		
		—		
□MK325 (1210)	1.25 (0.049)	D	—	2000
		F		
		H		
		N		
		Y		
□MK432 (1812)	1.5 (0.059)	—	500,1000	—
		M		
□MK432 (1812)	1.9 (0.075)	—	500,1000	—
		M		
□MK432 (1812)	2.0max (0.079)	—	500,1000	—
		M		
□MK432 (1812)	2.5 (0.098)	—	500,1000	—
		M		

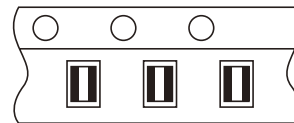
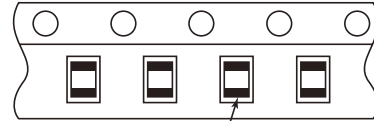
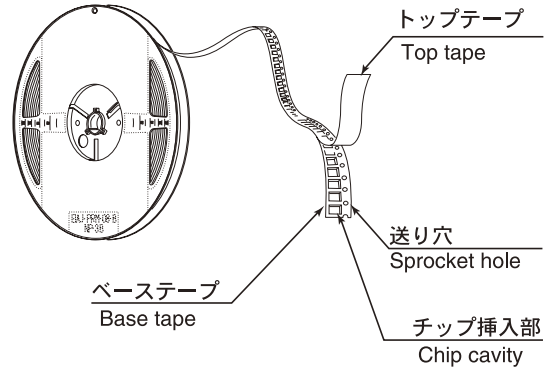
②テーピング材質 Taping material

紙テープ  
Card board carrier tape

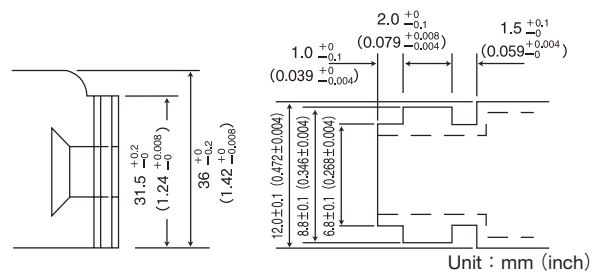
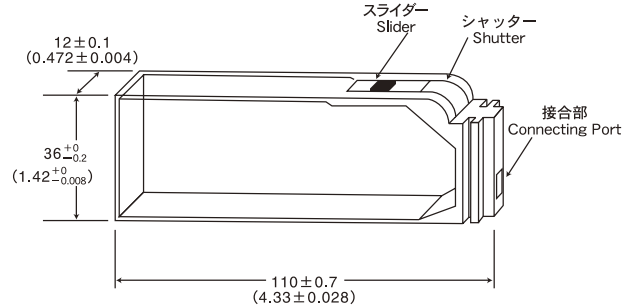
※プレスポケットタイプは、  
ボトムテープ無し。



エンボステープ  
Embossed Tape



③バルクカセット Bulk Cassette

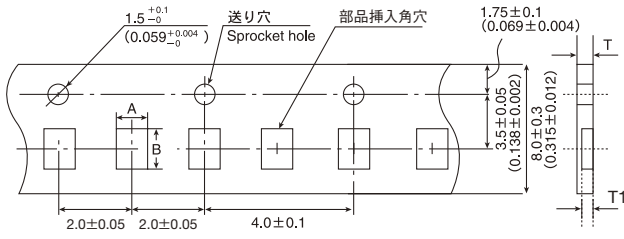


105, 107, 212形状で個別対応致しますのでお問い合わせ下さい。  
Please contact any of our offices for accepting your requirement according to dimensions 0402, 0603, 0805.(inch)



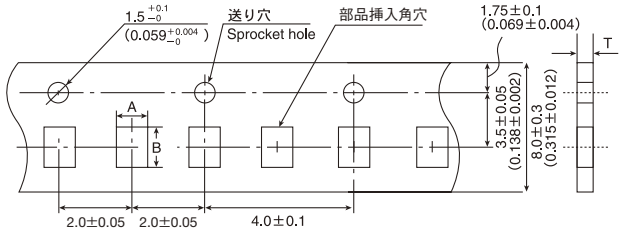
# 梱包 PACKAGING

③テーピング寸法 Taping dimensions  
紙テープ Paper Tape (8mm幅) (0.315inches wide)



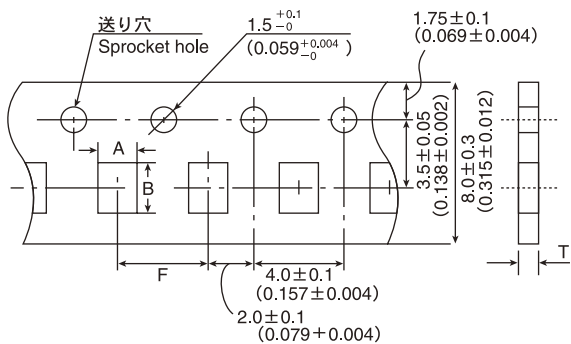
Type (EIA)	チップ挿入部 Chip Cavity		挿入ピッチ Insertion Pitch F	テープ厚み Tape Thickness	
	A	B		T	T1
□MK042 (01005)	0.25 (0.010)	0.45 (0.018)	2.0±0.05 (0.079±0.002)	0.36max. (0.014)	0.27max. (0.011)
□MK063 (0201)	0.37 (0.016)	0.67 (0.027)	2.0±0.05 (0.079±0.002)	0.45max. (0.018)	0.42max. (0.017)
□WK105 (0204)	0.65 (0.026)	1.15 (0.045)	2.0±0.05 (0.079±0.002)	0.45max (0.018max)	0.42max (0.017max)

Unit : mm (inch)



Type (EIA)	チップ挿入部 Chip Cavity		挿入ピッチ Insertion Pitch F	テープ厚み Tape Thickness T
	A	B		
□2K096 (0302)	0.72 (0.028)	1.02 (0.040)	2.0±0.05 (0.079±0.002)	0.45max.(0.018max) 0.6max.(0.024max)
□MK105 (0402)	0.65 (0.026)	1.15 (0.045)	2.0±0.05 (0.079±0.002)	0.8max.
□VK105 (0402)	0.65 (0.026)	1.15 (0.045)	2.0±0.05 (0.079±0.002)	0.31max.

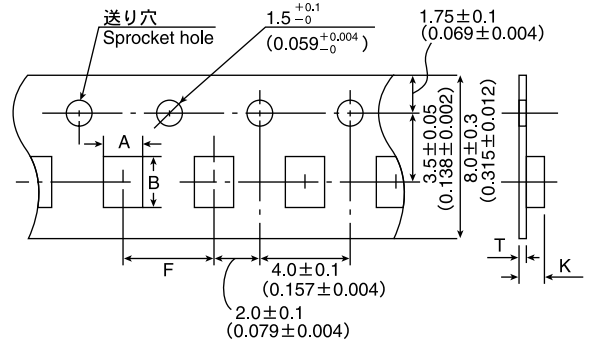
Unit : mm (inch)



Type (EIA)	チップ挿入部 Chip Cavity		挿入ピッチ Insertion Pitch F	テープ厚み Tape Thickness T
	A	B		
□MK107 (0603)	1.0 (0.039)	1.8 (0.071)	4.0±0.1 (0.157±0.004)	1.1max. (0.043max.)
□WK107 (0306)	1.0 (0.039)	1.8 (0.071)	4.0±0.1 (0.157±0.004)	1.1max. (0.043max.)
□2K110 (0504)	1.15 (0.045)	1.55 (0.061)	4.0±0.1 (0.157±0.004)	1.0max. (0.039max.)
□MK212 (0805)	1.65 (0.065)	2.4 (0.094)	4.0±0.1 (0.157±0.004)	1.1max. (0.043max.)
□WK212 (0508)				
□4K212 (0805)	2.0 (0.079)	3.6 (0.142)	4.0±0.1 (0.157±0.004)	1.1max. (0.043max.)
□2K212 (0805)				
□MK316 (1206)	2.0 (0.079)	3.6 (0.142)	4.0±0.1 (0.157±0.004)	1.1max. (0.043max.)
□WK316 (0612)				

Unit : mm (inch)

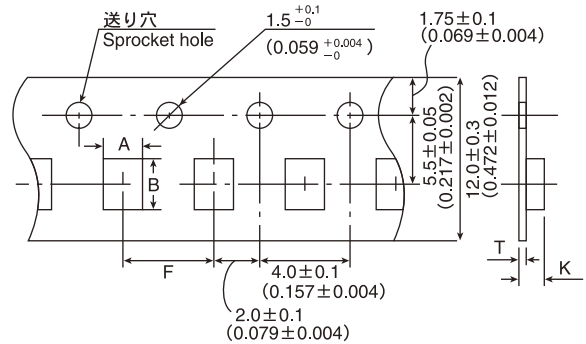
エンボステープ Embossed tape (8mm幅) (0.315inches wide)



Type (EIA)	チップ挿入部 Chip cavity		挿入ピッチ Insertion Pitch F	テープ厚み Tape Thickness	
	A	B		K	T
□WK107 (0306)	1.0 (0.039)	1.8 (0.071)	4.0±0.1 (0.157±0.004)	1.3max. (0.051max.)	0.25±0.1 (0.01±0.004)
□MK212 (0805)	1.65 (0.065)	2.4 (0.094)		3.4max. (0.134max.)	0.6max. (0.024max.)
□MK316 (1206)	2.0 (0.079)	3.6 (0.142)	4.0±0.1 (0.157±0.004)	3.4max. (0.134max.)	0.6max. (0.024max.)
□MK325 (1210)	2.8 (0.110)	3.6 (0.142)			

Unit : mm (inch)

エンボステープ Embossed tape (12mm幅) (0.472inches wide)

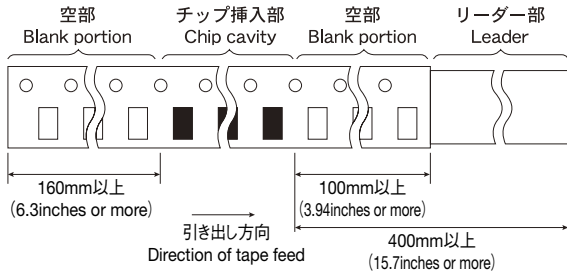


Type (EIA)	チップ挿入部 Chip cavity		挿入ピッチ Insertion Pitch F	テープ厚み Tape Thickness	
	A	B		K	T
□MK432 (1812)	3.7 (0.146)	4.9 (0.193)	8.0±0.1 (0.315±0.004)	4.0max. (0.157max.)	0.6max. (0.024max.)

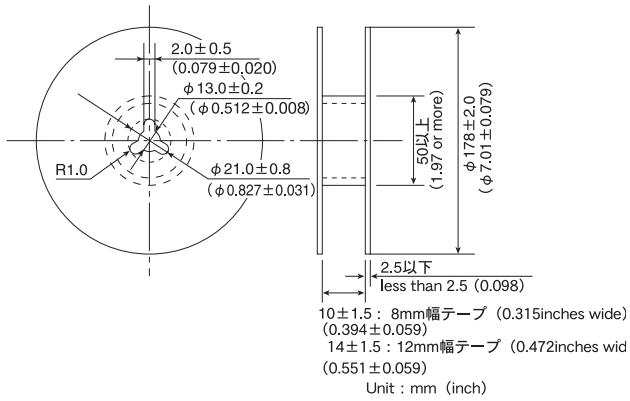
Unit : mm (inch)



④リーダー部／空部 Leader and Blank portion

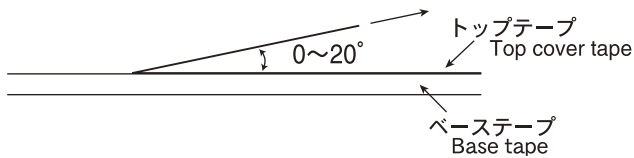


⑤リール寸法 Reel size

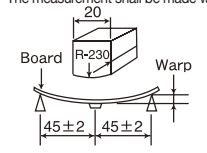


⑥トップテープ強度 Top Tape Strength

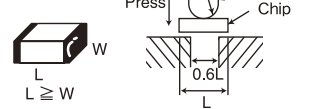
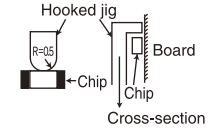
トップテープのはがし力は下図矢印方向にて0.1～0.7Nとなります。  
The top tape requires a peel-off force of 0.1～0.7N in the direction of the arrow as illustrated below.



Multilayer Ceramic Capacitor Chips

Item	Specified Value				Test Methods and Remarks
	Temperature Compensating (Class 1)		High Permittivity (Class 2)		
	Standard	High Frequency Type	Standard Note1	High Value	
1. Operating Temperature Range	-55 to +125°C		BJ : -55 to +125°C F : -25 to +85°C	-25 to +85°C	High Capacitance Type BJ (X7R) : -55~+125°C, BJ (X5R) : -55~+85°C E (Y5U) : -30~+85°C, F (Y5V) : -30~+85°C
2. Storage Temperature Range	-55 to +125°C		BJ : -55 to +125°C F : -25 to +85°C	-25 to +85°C	High Capacitance Type BJ (X7R) : -55~+125°C, BJ (X5R) : -55~+85°C E (Y5U) : -30~+85°C, F (Y5V) : -30~+85°C
3. Rated Voltage	50VDC, 25VDC, 16VDC	16VDC 50VDC	50VDC, 25VDC	50VDC, 35VDC, 25VDC 16VDC, 10VDC, 6.3VDC 4DVC, 2.5VDC	
4. Withstanding Voltage Between terminals	No breakdown or damage	No abnormality	No breakdown or damage		Applied voltage: Rated voltage ×3 (Class 1) Rated voltage ×2.5 (Class 2) Duration: 1 to 5 sec. Charge/discharge current: 50mA max. (Class 1,2)
5. Insulation Resistance	10000 MΩ min.		500 MΩ μF, or 10000 MΩ., whichever is the smaller. Note 5		Applied voltage: Rated voltage Duration: 60 ± 5 sec. Charge/discharge current: 50mA max.
6. Capacitance (Tolerance)	0.5 to 5 pF : ±0.25 pF 1 to 10 pF : ±0.5 pF 5 to 10 pF : ±1 pF 11 pF or over : ± 5% ±10% 105TYPE <sup>△</sup> , S <sup>△</sup> , T <sup>△</sup> , U <sup>△</sup> only 0.5~2pF : ±0.1pF 2.2~20pF : ±5%	0.5 to 2 pF : ±0.1 pF 2.2 to 5.1 pF : ±5%	BJ : ±10%, ±20% F : +80% -20%	BJ : ±10%, ±20% F : -20% / +80%	Measuring frequency : Class 1 : 1MHz ±10% (C ≤ 1000pF) 1 k Hz ±10% (C > 1000pF) Class 2 : 1 k Hz ±10% (C ≤ 10 μF) 120Hz ±10Hz (C > 10 μF) Measuring voltage : Note 4 Class 1 : 0.5~5Vrms (C ≤ 1000pF) 1 ± 0.2Vrms (C > 1000pF) Class 2 : 1 ± 0.2Vrms (C ≤ 10 μF) 0.5 ± 0.1Vrms (C > 10 μF) Bias application: None
7. Q or Tangent of Loss Angle (tan δ)	Under 30 pF : Q ≥ 400 + 20C 30 pF or over : Q ≥ 1000 C = Nominal capacitance	Refer to detailed specification	BJ : 2.5% max. (50V, 25V) F : 5.0% max. (50V, 25V) Note 4	BJ : 2.5% max. F : 7% max. Note 4	Multilayer: Measuring frequency : Class 1 : 1MHz ±10% (C ≤ 1000pF) 1 k Hz ±10% (C > 1000pF) Class 2 : 1 k Hz ±10% (C ≤ 10 μF) 120Hz ±10Hz (C > 10 μF) Measuring voltage : Note 4 Class 1 : 0.5~5Vrms (C ≤ 1000pF) 1 ± 0.2Vrms (C > 1000pF) Class 2 : 1 ± 0.2Vrms (C ≤ 10 μF) 0.5 ± 0.1Vrms (C > 10 μF) Bias application: None High-Frequency-Multilayer: Measuring frequency: 1GHz Measuring equipment: HP4291A Measuring jig: HP16192A
8. Temperature Characteristic of Capacitance	(Without voltage application) CK : 0 ± 250 CJ : 0 ± 120 CH : 0 ± 60 CG : 0 ± 30 RH : -220 ± 60 SK : -330 ± 250 SJ : -330 ± 120 SH : -330 ± 60 TK : -470 ± 250 TJ : -470 ± 120 UK : -750 ± 250 UJ : -750 ± 120 SL : +350 to -1000 (ppm/°C)	CH : 0 ± 60 RH : -220 ± 60 (ppm/°C)	BJ : ±10% (-25~85°C) F : +30% (-25~85°C) -80 BJ (X7R) : ±15% F (Y5V) : +22% -82	BJ : ±10% (-25~+85°C) F : +30% / -80% (-25~+85°C) BJ (X7R, X5R) : ±15% F (Y5V) : +22% / -82%	According to JIS C 5102 clause 7.12. Temperature compensating: Measurement of capacitance at 20°C and 85°C shall be made to calculate temperature characteristic by the following equation. $\frac{C_{85} - C_{20}}{C_{20} \times \Delta T} \times 10^6 \text{ (ppm/°C)}$ High permittivity: Change of maximum capacitance deviation in step 1 to 5 Temperature at step 1: +20°C Temperature at step 2: minimum operating temperature Temperature at step 3: +20°C (Reference temperature) Temperature at step 4: maximum operating temperature Temperature at step 5: +20°C Reference temperature for X7R, X5R, Y5U and Y5V shall be +25°C
9. Resistance to Flexure of Substrate	Appearance: No abnormality Capacitance change: Within ±5% or ±0.5 pF, whichever is larger.	Appearance: No abnormality Capacitance change: Within ±0.5 pF	Appearance: No abnormality Capacitance change: BJ : Within ±12.5% F : Within ±30%	Warp: 1mm Testing board: glass epoxy-resin substrate Thickness: 1.6mm (063 TYPE : 0.8mm) The measurement shall be made with board in the bent position.  (Unit: mm)	

Multilayer Ceramic Capacitor Chips

Item	Specified Value				Test Methods and Remarks
	Temperature Compensating (Class 1)		High Permittivity (Class 2)		
	Standard	High Frequency Type	Standard Note1	High Value	
10.Body Strength	—	No mechanical damage.	—	—	High Frequency Multilayer: Applied force: 5N Duration: 10 sec. 
11.Adhesion of Electrode	No separation or indication of separation of electrode.			Applied force: 5N Duration: 30±5 sec. 	
12.Solderability	At least 95% of terminal electrode is covered by new solder.			Solder temperature: 230±5°C Duration: 4±1 sec.	
13.Resistance to soldering	Appearance: No abnormality Capacitance change: Within ±2.5% or ±0.25pF, whichever is larger. Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±2.5% Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±7.5% (BJ) Within ±20% (F) tan δ: Initial value Note 4 Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Preconditioning: Thermal treatment (at 150°C for 1 hr) (Applicable to Class 2.) Solder temperature: 270±5°C Duration: 3±0.5 sec. Preheating conditions: 80 to 100°C, 2 to 5 min. or 5 to 10 min. 150 to 200°C, 2 to 5 min. or 5 to 10 min. Recovery: Recovery for the following period under the standard condition after the test. 6~24 hrs (Class 1) 24±2 hrs (Class 2)	
14.Thermal shock	Appearance: No abnormality Capacitance change: Within ±2.5% or ±0.25pF, whichever is larger. Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±0.25pF Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±7.5% (BJ) Within ±20% (F) tan δ: Initial value Note 4 Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Preconditioning: Thermal treatment (at 150°C for 1 hr) (Applicable to Class 2.) Conditions for 1 cycle: Step 1: Minimum operating temperature $+0_{-3}^{\circ}\text{C}$ 30±3 min. Step 2: Room temperature 2 to 3 min. Step 3: Maximum operating temperature $+0_{-3}^{\circ}\text{C}$ 30±3 min. Step 4: Room temperature 2 to 3 min. Number of cycles: 5 times Recovery after the test: 6~24 hrs (Class 1) 24±2 hrs (Class 2)	
15.Damp Heat (steady state)	Appearance: No abnormality Capacitance change: Within ±5% or ±0.5pF, whichever is larger. Q: $C \geq 30 \text{ pF} : Q \geq 350$ $10 \leq C < 30 \text{ pF} : Q \geq 275 + 2.5C$ $C < 10 \text{ pF} : Q \geq 200 + 10C$ C: Nominal capacitance Insulation resistance: 1000 MΩ min.	Appearance: No abnormality Capacitance change: Within ±0.5pF, Insulation resistance: 1000 MΩ min.	Appearance: No abnormality Capacitance change: BJ: Within ±12.5% F: Within ±30% tan δ: BJ: 5.0% max. F: 7.5% max. Note 4 Insulation resistance: 50 MΩ μF or 1000 MΩ whichever is smaller. Note 5	Appearance: No abnormality Capacitance change: BJ: Within ±12.5% Note 4 tan δ: BJ: 5.0% max. Note 4. F: 11.0% max. Insulation resistance: 50 MΩ μF or 1000 MΩ whichever is smaller. Note 5	Multilayer : Preconditioning: Thermal treatment (at 150°C for 1 hr) (Applicable to Class 2.) Temperature: 40±2°C Humidity: 90 to 95% RH Duration: 500 $+24_{-0}$ hrs Recovery: Recovery for the following period under the standard condition after the removal from test chamber. 6~24 hrs (Class 1) 24±2 hrs (Class 2) High-Frequency Multilayer: Temperature: 60±2°C Humidity: 90 to 95% RH Duration: 500 $+24_{-0}$ hrs Recovery: Recovery for the following period under the standard condition after the removal from test chamber. 6~24 hrs (Class 1)

## Multilayer Ceramic Capacitor Chips

Item	Specified Value				Test Methods and Remarks
	Temperature Compensating (Class 1)		High Permittivity (Class 2)		
	Standard	High Frequency Type	Standard Note1	High Value	
16>Loading under Damp Heat	Appearance: No abnormality Capacitance change: Within $\pm 7.5\%$ or $\pm 0.75\text{pF}$ , whichever is larger. Q: $C \geq 30\text{pF}$ : $Q \geq 200$ $C < 30\text{pF}$ : $Q \geq 100 + 10C/3$ C : Nominal capacitance Insulation resistance: 500 M $\Omega$ min.	Appearance: No abnormality Capacitance change: $C \leq 2\text{pF}$ : Within $\pm 0.4\text{pF}$ $C > 2\text{pF}$ : Within $\pm 0.75\text{pF}$ C : Nominal capacitance Insulation resistance: 500 M $\Omega$ min.	Appearance: No abnormality Capacitance change: BJ: Within $\pm 12.5\%$ F: Within $\pm 30\%$ Note 4 tan $\delta$ : BJ: 5.0% max. F: 7.5% max. Note 4 Insulation resistance: 25 M $\Omega$ $\mu\text{F}$ or 500 M $\Omega$ , whichever is the smaller. Note 5	Appearance: No abnormality Capacitance change: BJ : Within $\pm 12.5\%$ F : Within $\pm 30\%$ Note 4 tan $\delta$ : BJ : 5.0% max. F : 11% max. Note 4 Insulation resistance: 25 M $\Omega$ $\mu\text{F}$ or 500 M $\Omega$ , whichever is the smaller. Note 5	According to JIS C 5102 Clause 9. 9. Multilayer: Preconditioning: Voltage treatment (Class 2) Temperature: $40 \pm 2^\circ\text{C}$ Humidity: 90 to 95% RH Duration: $500^{+24}_0$ hrs Applied voltage: Rated voltage Charge and discharge current: 50mA max. (Class 1,2) Recovery: Recovery for the following period under the standard condition after the removal from test chamber. 6~24 hrs (Class 1) 24 $\pm 2$ hrs (Class 2) High-Frequency Multilayer: Temperature: $60 \pm 2^\circ\text{C}$ Humidity: 90 to 95% RH Duration: $500^{+24}_0$ hrs Applied voltage: Rated voltage Charge and discharge current: 50mA max. Recovery: 6~24 hrs of recovery under the standard condition after the removal from test chamber.
17>Loading at High Temperature	Appearance: No abnormality Capacitance change: Within $\pm 3\%$ or $\pm 0.3\text{pF}$ , whichever is larger. Q: $C \geq 30\text{pF}$ : $Q \geq 350$ $10 \leq C < 30\text{pF}$ : $Q \geq 275 + 2.5C$ $C < 10\text{pF}$ : $Q \geq 200 + 10C$ C : Nominal capacitance Insulation resistance: 1000 M $\Omega$ min.	Appearance: No abnormality Capacitance change: Within $\pm 3\%$ or $\pm 0.3\text{pF}$ , whichever is larger. Insulation resistance: 1000 M $\Omega$ min.	Appearance: No abnormality Capacitance change: BJ: Within $\pm 12.5\%$ F: Within $\pm 30\%$ Note 4 tan $\delta$ : BJ: 4.0% max. F: 7.5% max. Note 4 Insulation resistance: 50 M $\Omega$ $\mu\text{F}$ or 1000 M $\Omega$ , whichever is smaller. Note 5	Appearance: No abnormality Capacitance change: BJ : Within $\pm 12.5\%$ Within $\pm 20\% \text{**}$ Within $\pm 25\% \text{**}$ F : Within $\pm 30\%$ Note 4 tan $\delta$ : BJ : 5.0% max. F : 11% max. Note 4 Insulation resistance: 50 M $\Omega$ $\mu\text{F}$ or 1000 M $\Omega$ , whichever is smaller. Note 5	According to JIS C 5102 clause 9.10. Multilayer: Preconditioning: Voltage treatment (Class 2) Temperature: $125 \pm 3^\circ\text{C}$ (Class 1, Class 2: B, BJ (X7R)) $85 \pm 2^\circ\text{C}$ (Class 2: BJ,F) Duration: $1000^{+48}_0$ hrs Applied voltage: Rated voltage $\times 2$ Note 6 Recovery: Recovery for the following period under the standard condition after the removal from test chamber. 6~24 hrs (Class 1) 24 $\pm 2$ hrs (Class 2) High-Frequency Multilayer: Temperature: $125 \pm 3^\circ\text{C}$ (Class 1) Duration: $1000^{+48}_0$ hrs Applied voltage: Rated voltage $\times 2$ Recovery: 6~24 hrs of recovery under the standard condition after the removal from test chamber.

Note 1 :For 105 type, specified in "High value".

Note 2 :Thermal treatment (Multilayer): 1 hr of thermal treatment at  $150 \pm 0 / -10^\circ\text{C}$  followed by  $24 \pm 2$  hrs of recovery under the standard condition shall be performed before the measurement.

Note 3 :Voltage treatment (Multilayer): 1 hr of voltage treatment under the specified temperature and voltage for testing followed by  $24 \pm 2$  hrs of recovery under the standard condition shall be performed before the measurement.

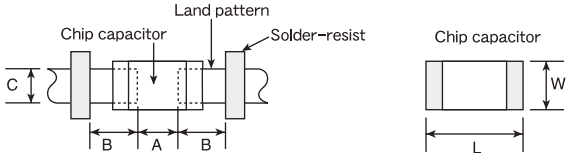
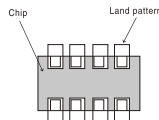
Note 4, 5 :The figure indicates typical inspection. Please refer to individual specifications.

Note 6 :Some of the parts are applicable in rated voltage  $\times 1.5$ . Please refer to individual specifications.

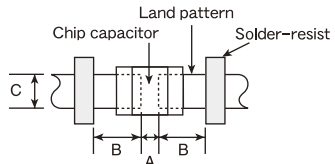
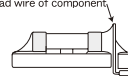

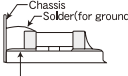
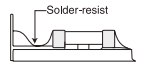
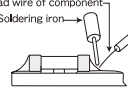
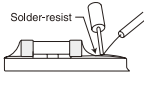


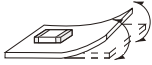
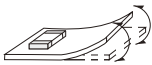
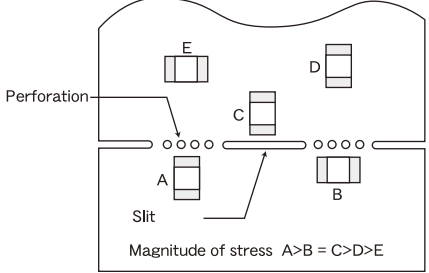
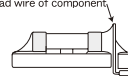

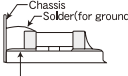
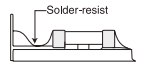
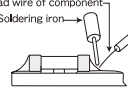
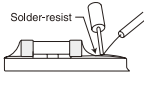


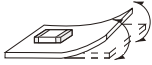
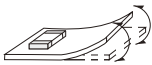
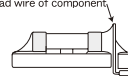

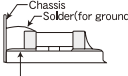
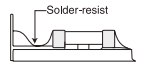
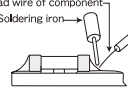
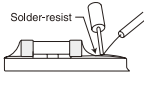


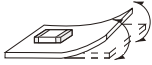
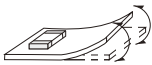
Note on standard condition: "standard condition" referred to herein is defined as follows: 5 to  $35^\circ\text{C}$  of temperature, 45 to 85% relative humidity, and 86 to 106kPa of air pressure.

When there are questions concerning measurement results: In order to provide correlation data, the test shall be conducted under condition of  $20 \pm 2^\circ\text{C}$  of temperature, 60 to 70% relative humidity, and 86 to 106kPa of air pressure. Unless otherwise specified, all the tests are conducted under the "standard condition."

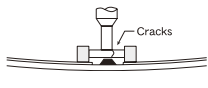
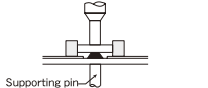
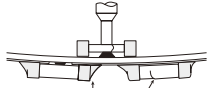
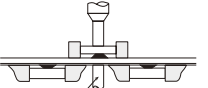
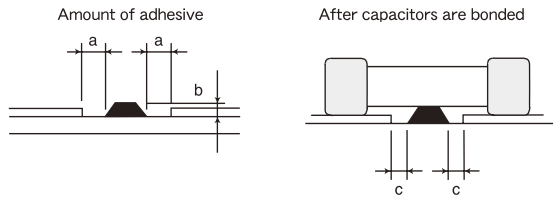
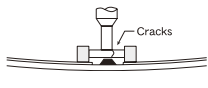
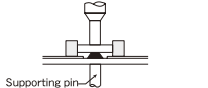
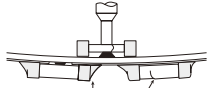
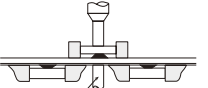
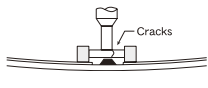
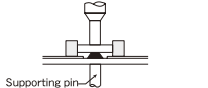
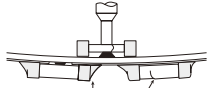
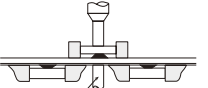
Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations																																																																																																																																		
1.Circuit Design	<p>Verification of operating environment, electrical rating and performance</p> <p>1. A malfunction in medical equipment, spacecraft, nuclear reactors, etc. may cause serious harm to human life or have severe social ramifications. As such, any capacitors to be used in such equipment may require higher safety and/or reliability considerations and should be clearly differentiated from components used in general purpose applications.</p> <p>Operating Voltage (Verification of Rated voltage)</p> <p>1. The operating voltage for capacitors must always be lower than their rated values.</p> <p>If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages should be lower than the rated value of the capacitor chosen. For a circuit where both an AC and a pulse voltage may be present, the sum of their peak voltages should also be lower than the capacitor's rated voltage.</p> <p>2. Even if the applied voltage is lower than the rated value, the reliability of capacitors might be reduced if either a high frequency AC voltage or a pulse voltage having rapid rise time is present in the circuit.</p>																																																																																																																																			
2.PCB Design	<p>Pattern configurations (Design of Land-patterns)</p> <p>1. When capacitors are mounted on a PCB, the amount of solder used (size of fillet) can directly affect capacitor performance. Therefore, the following items must be carefully considered in the design of solder land patterns:</p> <p>(1) The amount of solder applied can affect the ability of chips to withstand mechanical stresses which may lead to breaking or cracking. Therefore, when designing land-patterns it is necessary to consider the appropriate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets.</p> <p>(2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by solder-resist.</p>	<p>1.The following diagrams and tables show some examples of recommended patterns to prevent excessive solder amounts. (larger fillets which extend above the component end terminations)</p> <p>Examples of improper pattern designs are also shown.</p> <p>(1) Recommended land dimensions for a typical chip capacitor land patterns for PCBs</p>  <p>Recommended land dimensions for wave-soldering (unit: mm)</p> <table border="1" data-bbox="849 1255 1228 1430"> <thead> <tr> <th>Type</th> <th>107</th> <th>212</th> <th>316</th> <th>325</th> </tr> </thead> <tbody> <tr> <td rowspan="2">Size</td> <td>L</td> <td>1.6</td> <td>2.0</td> <td>3.2</td> <td>3.2</td> </tr> <tr> <td>W</td> <td>0.8</td> <td>1.25</td> <td>1.6</td> <td>2.5</td> </tr> <tr> <td>A</td> <td>0.8~1.0</td> <td>1.0~1.4</td> <td>1.8~2.5</td> <td>1.8~2.5</td> </tr> <tr> <td>B</td> <td>0.5~0.8</td> <td>0.8~1.5</td> <td>0.8~1.7</td> <td>0.8~1.7</td> </tr> <tr> <td>C</td> <td>0.6~0.8</td> <td>0.9~1.2</td> <td>1.2~1.6</td> <td>1.8~2.5</td> </tr> </tbody> </table> <p>Recommended land dimensions for reflow-soldering (unit: mm)</p> <table border="1" data-bbox="849 1496 1452 1681"> <thead> <tr> <th>Type</th> <th>042</th> <th>063</th> <th>105</th> <th>107</th> <th>212</th> <th>316</th> <th>325</th> <th>432</th> </tr> </thead> <tbody> <tr> <td rowspan="2">Size</td> <td>L</td> <td>0.4</td> <td>0.6</td> <td>1.0</td> <td>1.6</td> <td>2.0</td> <td>3.2</td> <td>3.2</td> <td>4.5</td> </tr> <tr> <td>W</td> <td>0.2</td> <td>0.3</td> <td>0.5</td> <td>0.8</td> <td>1.25</td> <td>1.6</td> <td>2.5</td> <td>3.2</td> </tr> <tr> <td>A</td> <td>0.15~0.25</td> <td>0.20~0.30</td> <td>0.45~0.55</td> <td>0.8~1.0</td> <td>0.8~1.2</td> <td>1.8~2.5</td> <td>1.8~2.5</td> <td>2.5~3.5</td> </tr> <tr> <td>B</td> <td>0.10~0.20</td> <td>0.20~0.30</td> <td>0.40~0.50</td> <td>0.6~0.8</td> <td>0.8~1.2</td> <td>1.0~1.5</td> <td>1.0~1.5</td> <td>1.5~1.8</td> </tr> <tr> <td>C</td> <td>0.15~0.30</td> <td>0.25~0.40</td> <td>0.45~0.55</td> <td>0.6~0.8</td> <td>0.9~1.6</td> <td>1.2~2.0</td> <td>1.8~3.2</td> <td>2.3~3.5</td> </tr> </tbody> </table> <p>Excess solder can affect the ability of chips to withstand mechanical stresses. Therefore, please take proper precautions when designing land-patterns.</p>  <table border="1" data-bbox="849 1758 997 1921"> <thead> <tr> <th>Type</th> <th>212 (4 circuits)</th> </tr> </thead> <tbody> <tr> <td rowspan="2">Size</td> <td>L</td> <td>2.0</td> </tr> <tr> <td>W</td> <td>1.25</td> </tr> <tr> <td>a</td> <td>0.5~0.6</td> </tr> <tr> <td>b</td> <td>0.5~0.6</td> </tr> <tr> <td>c</td> <td>0.2~0.3</td> </tr> <tr> <td>d</td> <td>0.5</td> </tr> </tbody> </table> <table border="1" data-bbox="849 1932 1181 2107"> <thead> <tr> <th>Type</th> <th>212 (2 circuits)</th> <th>110 (2 circuits)</th> <th>096 (2 circuits)</th> </tr> </thead> <tbody> <tr> <td rowspan="2">Size</td> <td>L</td> <td>2.0</td> <td>1.37</td> <td>0.9</td> </tr> <tr> <td>W</td> <td>1.25</td> <td>1.0</td> <td>0.6</td> </tr> <tr> <td>a</td> <td>0.5~0.6</td> <td>0.35~0.45</td> <td>0.25~0.35</td> </tr> <tr> <td>b</td> <td>0.5~0.6</td> <td>0.55~0.65</td> <td>0.15~0.25</td> </tr> <tr> <td>c</td> <td>0.5~0.6</td> <td>0.3~0.4</td> <td>0.15~0.25</td> </tr> <tr> <td>d</td> <td>1.0</td> <td>0.64</td> <td>0.45</td> </tr> </tbody> </table>	Type	107	212	316	325	Size	L	1.6	2.0	3.2	3.2	W	0.8	1.25	1.6	2.5	A	0.8~1.0	1.0~1.4	1.8~2.5	1.8~2.5	B	0.5~0.8	0.8~1.5	0.8~1.7	0.8~1.7	C	0.6~0.8	0.9~1.2	1.2~1.6	1.8~2.5	Type	042	063	105	107	212	316	325	432	Size	L	0.4	0.6	1.0	1.6	2.0	3.2	3.2	4.5	W	0.2	0.3	0.5	0.8	1.25	1.6	2.5	3.2	A	0.15~0.25	0.20~0.30	0.45~0.55	0.8~1.0	0.8~1.2	1.8~2.5	1.8~2.5	2.5~3.5	B	0.10~0.20	0.20~0.30	0.40~0.50	0.6~0.8	0.8~1.2	1.0~1.5	1.0~1.5	1.5~1.8	C	0.15~0.30	0.25~0.40	0.45~0.55	0.6~0.8	0.9~1.6	1.2~2.0	1.8~3.2	2.3~3.5	Type	212 (4 circuits)	Size	L	2.0	W	1.25	a	0.5~0.6	b	0.5~0.6	c	0.2~0.3	d	0.5	Type	212 (2 circuits)	110 (2 circuits)	096 (2 circuits)	Size	L	2.0	1.37	0.9	W	1.25	1.0	0.6	a	0.5~0.6	0.35~0.45	0.25~0.35	b	0.5~0.6	0.55~0.65	0.15~0.25	c	0.5~0.6	0.3~0.4	0.15~0.25	d	1.0	0.64	0.45
Type	107	212	316	325																																																																																																																																
Size	L	1.6	2.0	3.2	3.2																																																																																																																															
	W	0.8	1.25	1.6	2.5																																																																																																																															
A	0.8~1.0	1.0~1.4	1.8~2.5	1.8~2.5																																																																																																																																
B	0.5~0.8	0.8~1.5	0.8~1.7	0.8~1.7																																																																																																																																
C	0.6~0.8	0.9~1.2	1.2~1.6	1.8~2.5																																																																																																																																
Type	042	063	105	107	212	316	325	432																																																																																																																												
Size	L	0.4	0.6	1.0	1.6	2.0	3.2	3.2	4.5																																																																																																																											
	W	0.2	0.3	0.5	0.8	1.25	1.6	2.5	3.2																																																																																																																											
A	0.15~0.25	0.20~0.30	0.45~0.55	0.8~1.0	0.8~1.2	1.8~2.5	1.8~2.5	2.5~3.5																																																																																																																												
B	0.10~0.20	0.20~0.30	0.40~0.50	0.6~0.8	0.8~1.2	1.0~1.5	1.0~1.5	1.5~1.8																																																																																																																												
C	0.15~0.30	0.25~0.40	0.45~0.55	0.6~0.8	0.9~1.6	1.2~2.0	1.8~3.2	2.3~3.5																																																																																																																												
Type	212 (4 circuits)																																																																																																																																			
Size	L	2.0																																																																																																																																		
	W	1.25																																																																																																																																		
a	0.5~0.6																																																																																																																																			
b	0.5~0.6																																																																																																																																			
c	0.2~0.3																																																																																																																																			
d	0.5																																																																																																																																			
Type	212 (2 circuits)	110 (2 circuits)	096 (2 circuits)																																																																																																																																	
Size	L	2.0	1.37	0.9																																																																																																																																
	W	1.25	1.0	0.6																																																																																																																																
a	0.5~0.6	0.35~0.45	0.25~0.35																																																																																																																																	
b	0.5~0.6	0.55~0.65	0.15~0.25																																																																																																																																	
c	0.5~0.6	0.3~0.4	0.15~0.25																																																																																																																																	
d	1.0	0.64	0.45																																																																																																																																	

Precautions on the use of Multilayer Ceramic Capacitors

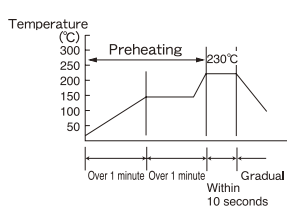
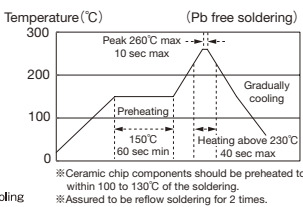
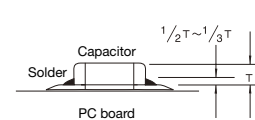
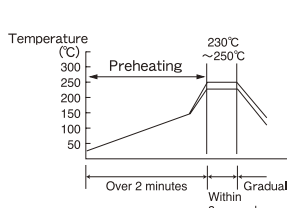
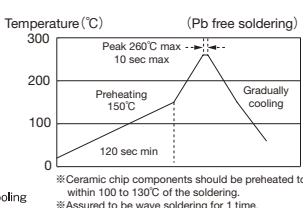
Stages	Precautions	Technical considerations																																																				
<p>2.PCB Design</p>	<p>Pattern configurations (Capacitor layout on panelized [breakaway] PC boards)</p> <p>1. After capacitors have been mounted on the boards, chips can be subjected to mechanical stresses in subsequent manufacturing processes (PCB cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering the reflow soldered boards etc.) For this reason, planning pattern configurations and the position of SMD capacitors should be carefully performed to minimize stress.</p>	<p>LWDC Recommended land dimensions for reflow-soldering</p>  <table border="1" data-bbox="853 469 1236 655"> <thead> <tr> <th>Type</th> <th>105</th> <th>107</th> <th>212</th> <th>316</th> </tr> </thead> <tbody> <tr> <td rowspan="2">Size</td> <td>W</td> <td>1.0</td> <td>1.6</td> <td>2.0</td> <td>3.2</td> </tr> <tr> <td>L</td> <td>0.52</td> <td>0.8</td> <td>1.25</td> <td>1.6</td> </tr> <tr> <td>A</td> <td>0.18~0.22</td> <td>0.25~0.3</td> <td>0.5~0.7</td> <td>0.8~1.0</td> </tr> <tr> <td>B</td> <td>0.2~0.25</td> <td>0.3~0.4</td> <td>0.4~0.5</td> <td>0.4~0.5</td> </tr> <tr> <td>C</td> <td>0.9~1.1</td> <td>1.5~1.7</td> <td>1.9~2.1</td> <td>3.0~3.4</td> </tr> </tbody> </table> <p>(unit: mm)</p> <p>(2) Examples of good and bad solder application</p> <table border="1" data-bbox="845 753 1452 1190"> <thead> <tr> <th>Items</th> <th>Not recommended</th> <th>Recommended</th> </tr> </thead> <tbody> <tr> <td>Mixed mounting of SMD and leaded components</td> <td></td> <td></td> </tr> <tr> <td>Component placement close to the chassis</td> <td></td> <td></td> </tr> <tr> <td>Hand-soldering of leaded components near mounted components</td> <td></td> <td></td> </tr> <tr> <td>Horizontal component placement</td> <td></td> <td></td> </tr> </tbody> </table> <p>1-1. The following are examples of good and bad capacitor layout; SMD capacitors should be located to minimize any possible mechanical stresses from board warp or deflection.</p> <table border="1" data-bbox="845 1299 1452 1452"> <thead> <tr> <th></th> <th>Not recommended</th> <th>Recommended</th> </tr> </thead> <tbody> <tr> <td>Deflection of the board</td> <td></td> <td></td> </tr> </tbody> </table> <p>1-2. To layout the capacitors for the breakaway PC board, it should be noted that the amount of mechanical stresses given will vary depending on capacitor layout. The example below shows recommendations for better design.</p>  <p>Magnitude of stress <math>A &gt; B = C &gt; D &gt; E</math></p> <p>1-3. When breaking PC boards along their perforations, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful to most stressful: push-back, slit, V-grooving, and perforation. Thus, any ideal SMD capacitor layout must also consider the PCB splitting procedure.</p>	Type	105	107	212	316	Size	W	1.0	1.6	2.0	3.2	L	0.52	0.8	1.25	1.6	A	0.18~0.22	0.25~0.3	0.5~0.7	0.8~1.0	B	0.2~0.25	0.3~0.4	0.4~0.5	0.4~0.5	C	0.9~1.1	1.5~1.7	1.9~2.1	3.0~3.4	Items	Not recommended	Recommended	Mixed mounting of SMD and leaded components			Component placement close to the chassis			Hand-soldering of leaded components near mounted components			Horizontal component placement				Not recommended	Recommended	Deflection of the board		
		Type	105	107	212	316																																																
Size	W	1.0	1.6	2.0	3.2																																																	
	L	0.52	0.8	1.25	1.6																																																	
A	0.18~0.22	0.25~0.3	0.5~0.7	0.8~1.0																																																		
B	0.2~0.25	0.3~0.4	0.4~0.5	0.4~0.5																																																		
C	0.9~1.1	1.5~1.7	1.9~2.1	3.0~3.4																																																		
Items	Not recommended	Recommended																																																				
Mixed mounting of SMD and leaded components																																																						
Component placement close to the chassis																																																						
Hand-soldering of leaded components near mounted components																																																						
Horizontal component placement																																																						
	Not recommended	Recommended																																																				
Deflection of the board																																																						

Precautions on the use of Multilayer Ceramic Capacitors

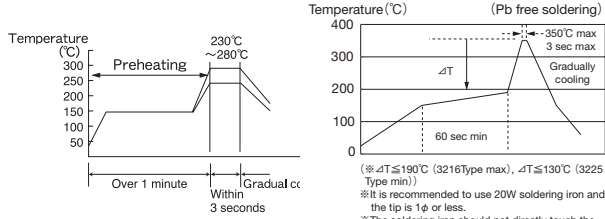
Stages	Precautions	Technical considerations																	
<p>3.Considerations for auto-matic placement</p>	<p>Adjustment of mounting machine</p> <ol style="list-style-type: none"> <li>Excessive impact load should not be imposed on the capacitors when mounting onto the PC boards.</li> <li>The maintenance and inspection of the mounters should be conducted periodically.</li> </ol> <p>Selection of Adhesives</p> <ol style="list-style-type: none"> <li>Mounting capacitors with adhesives in preliminary assembly, before the soldering stage, may lead to degraded capacitor characteristics unless the following factors are appropriately checked; the size of land patterns, type of adhesive, amount applied, hardening temperature and hardening period. Therefore, it is imperative to consult the manufacturer of the adhesives on proper usage and amounts of adhesive to use.</li> </ol>	<ol style="list-style-type: none"> <li>If the lower limit of the pick-up nozzle is low, too much force may be imposed on the capacitors, causing damage. To avoid this, the following points should be considered before lowering the pick-up nozzle:                     <ol style="list-style-type: none"> <li>The lower limit of the pick-up nozzle should be adjusted to the surface level of the PC board after correcting for deflection of the board.</li> <li>The pick-up pressure should be adjusted between 1 and 3 N static loads.</li> <li>To reduce the amount of deflection of the board caused by impact of the pick-up nozzle, supporting pins or back-up pins should be used under the PC board. The following diagrams show some typical examples of good pick-up nozzle placement:</li> </ol> </li> </ol> <table border="1" data-bbox="849 524 1452 797"> <thead> <tr> <th></th> <th>Not recommended</th> <th>Recommended</th> </tr> </thead> <tbody> <tr> <td>Single-sided mounting</td> <td></td> <td></td> </tr> <tr> <td>Double-sided mounting</td> <td></td> <td></td> </tr> </tbody> </table> <ol style="list-style-type: none"> <li>As the alignment pin wears out, adjustment of the nozzle height can cause chipping or cracking of the capacitors because of mechanical impact on the capacitors. To avoid this, the monitoring of the width between the alignment pin in the stopped position, and maintenance, inspection and replacement of the pin should be conducted periodically.</li> </ol> <ol style="list-style-type: none"> <li>Some adhesives may cause reduced insulation resistance. The difference between the shrinkage percentage of the adhesive and that of the capacitors may result in stresses on the capacitors and lead to cracking. Moreover, too little or too much adhesive applied to the board may adversely affect component placement, so the following precautions should be noted in the application of adhesives.                     <ol style="list-style-type: none"> <li>Required adhesive characteristics                             <ol style="list-style-type: none"> <li>The adhesive should be strong enough to hold parts on the board during the mounting &amp; solder process.</li> <li>The adhesive should have sufficient strength at high temperatures.</li> <li>The adhesive should have good coating and thickness consistency.</li> <li>The adhesive should be used during its prescribed shelf life.</li> <li>The adhesive should harden rapidly</li> <li>The adhesive must not be contaminated.</li> <li>The adhesive should have excellent insulation characteristics.</li> <li>The adhesive should not be toxic and have no emission of toxic gasses.</li> </ol> </li> <li>The recommended amount of adhesives is as follows;                             <table border="1" data-bbox="849 1467 1404 1589"> <thead> <tr> <th>Figure</th> <th>212/316 case sizes as examples</th> </tr> </thead> <tbody> <tr> <td>a</td> <td>0.3mm min</td> </tr> <tr> <td>b</td> <td>100 ~ 120 μm</td> </tr> <tr> <td>c</td> <td>Adhesives should not contact the pad</td> </tr> </tbody> </table> </li> </ol> </li> </ol> <div data-bbox="869 1659 1428 1856">  <p>Amount of adhesive</p> <p>After capacitors are bonded</p> </div>		Not recommended	Recommended	Single-sided mounting			Double-sided mounting			Figure	212/316 case sizes as examples	a	0.3mm min	b	100 ~ 120 μm	c	Adhesives should not contact the pad
	Not recommended	Recommended																	
Single-sided mounting																			
Double-sided mounting																			
Figure	212/316 case sizes as examples																		
a	0.3mm min																		
b	100 ~ 120 μm																		
c	Adhesives should not contact the pad																		



Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations
4. Soldering	<p><b>Selection of Flux</b></p> <p>1. Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use;</p> <p>(1) Flux used should be with less than or equal to 0.1 wt% (equivalent to chlorine) of halogenated content. Flux having a strong acidity content should not be applied.</p> <p>(2) When soldering capacitors on the board, the amount of flux applied should be controlled at the optimum level.</p> <p>(3) When using water-soluble flux, special care should be taken to properly clean the boards.</p> <p><b>Soldering</b></p> <p>Temperature, time, amount of solder, etc. are specified in accordance with the following recommended conditions.</p> <p>Sn-Zn solder paste can affect MLCC reliability performance. Please contact us prior to usage.</p>	<p>1-1. When too much halogenated substance (Chlorine, etc.) content is used to activate the flux, or highly acidic flux is used, an excessive amount of residue after soldering may lead to corrosion of the terminal electrodes or degradation of insulation resistance on the surface of the capacitors.</p> <p>1-2. Flux is used to increase solderability in flow soldering, but if too much is applied, a large amount of flux gas may be emitted and may detrimentally affect solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system.</p> <p>1-3. Since the residue of water-soluble flux is easily dissolved by water content in the air, the residue on the surface of capacitors in high humidity conditions may cause a degradation of insulation resistance and therefore affect the reliability of the components. The cleaning methods and the capability of the machines used should also be considered carefully when selecting water-soluble flux.</p> <p>1-1. Preheating when soldering</p> <p>Heating: Ceramic chip components should be preheated to within 100 to 130°C of the soldering.</p> <p>Cooling: The temperature difference between the components and cleaning process should not be greater than 100°C.</p> <p>Ceramic chip capacitors are susceptible to thermal shock when exposed to rapid or concentrated heating or rapid cooling. Therefore, the soldering process must be conducted with great care so as to prevent malfunction of the components due to excessive thermal shock.</p> <p><b>Recommended conditions for soldering</b></p> <p>[Reflow soldering]</p> <p>Temperature profile</p>   <p>Caution</p> <p>1. The ideal condition is to have solder mass (fillet) controlled to 1/2 to 1/3 of the thickness of the capacitor, as shown below:</p>  <p>2. Because excessive dwell times can detrimentally affect solderability, soldering duration should be kept as close to recommended times as possible.</p> <p>[Wave soldering]</p> <p>Temperature profile</p>   <p>Caution</p> <p>1. Make sure the capacitors are preheated sufficiently.</p> <p>2. The temperature difference between the capacitor and melted solder should not be greater than 100 to 130°C</p> <p>3. Cooling after soldering should be as gradual as possible.</p> <p>4. Wave soldering must not be applied to the capacitors designated as for reflow soldering only.</p>

Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations
4. Soldering		<p>[Hand soldering]</p> <p>Temperature profile</p>  <p>Caution</p> <ol style="list-style-type: none"> <li>1. Use a 20W soldering iron with a maximum tip diameter of 1.0 mm.</li> <li>2. The soldering iron should not directly touch the capacitor.</li> </ol>
5. Cleaning	<p>Cleaning conditions</p> <ol style="list-style-type: none"> <li>1. When cleaning the PC board after the capacitors are all mounted, select the appropriate cleaning solution according to the type of flux used and purpose of the cleaning (e.g. to remove soldering flux or other materials from the production process.)</li> <li>2. Cleaning conditions should be determined after verifying, through a test run, that the cleaning process does not affect the capacitor's characteristics.</li> </ol>	<ol style="list-style-type: none"> <li>1. The use of inappropriate solutions can cause foreign substances such as flux residue to adhere to the capacitor or deteriorate the capacitor's outer coating, resulting in a degradation of the capacitor's electrical properties (especially insulation resistance).</li> <li>2. Inappropriate cleaning conditions (insufficient or excessive cleaning) may detrimentally affect the performance of the capacitors.</li> </ol> <p>(1) Excessive cleaning</p> <p>In the case of ultrasonic cleaning, too much power output can cause excessive vibration of the PC board which may lead to the cracking of the capacitor or the soldered portion, or decrease the terminal electrodes' strength. Thus the following conditions should be carefully checked;</p> <p>Ultrasonic output            Below 20 W/ℓ          Ultrasonic frequency      Below 40 kHz          Ultrasonic washing period 5 min. or less</p>
6. Post cleaning processes	<ol style="list-style-type: none"> <li>1. With some type of resins a decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the capacitor's performance.</li> <li>2. When a resin's hardening temperature is higher than the capacitor's operating temperature, the stresses generated by the excess heat may lead to capacitor damage or destruction. The use of such resins, molding materials etc. is not recommended.</li> </ol>	
7. Handling	<p>Breakaway PC boards (splitting along perforations)</p> <ol style="list-style-type: none"> <li>1. When splitting the PC board after mounting capacitors and other components, care is required so as not to give any stresses of deflection or twisting to the board.</li> <li>2. Board separation should not be done manually, but by using the appropriate devices.</li> </ol> <p>Mechanical considerations</p> <ol style="list-style-type: none"> <li>1. Be careful not to subject the capacitors to excessive mechanical shocks.                     <ol style="list-style-type: none"> <li>(1) If ceramic capacitors are dropped onto the floor or a hard surface, they should not be used.</li> <li>(2) When handling the mounted boards, be careful that the mounted components do not come in contact with or bump against other boards or components.</li> </ol> </li> </ol>	

## Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations				
8.Storage conditions	<p>Storage</p> <p>1. To maintain the solderability of terminal electrodes and to keep the packaging material in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible.</p> <p>• Recommended conditions</p> <table border="0" data-bbox="411 417 724 467"> <tr> <td>Ambient temperature</td> <td>Below 30°C</td> </tr> <tr> <td>Humidity</td> <td>Below 70% RH</td> </tr> </table> <p>The ambient temperature must be kept below 40°C. Even under ideal storage conditions capacitor electrode solderability decreases as time passes, so should be used within 6 months from the time of delivery.</p> <p>• Ceramic chip capacitors should be kept where no chlorine or sulfur exists in the air.</p> <p>2. The capacitance value of high dielectric constant capacitors (type 2 &amp;3) will gradually decrease with the passage of time, so this should be taken into consideration in the circuit design. If such a capacitance reduction occurs, a heat treatment of 150°C for 1hour will return the capacitance to its initial level.</p>	Ambient temperature	Below 30°C	Humidity	Below 70% RH	<p>1. If the parts are stored in a high temperature and humidity environment, problems such as reduced solderability caused by oxidation of terminal electrodes and deterioration of taping/package materials may take place. For this reason, components should be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the capacitors.</p>
Ambient temperature	Below 30°C					
Humidity	Below 70% RH					